

3.3V CMOS OCTAL TRANSPARENT LATCH

FEATURES:

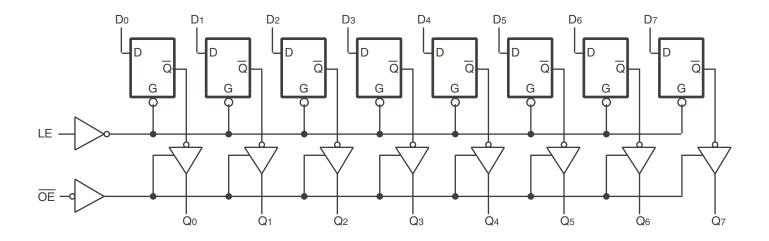
- 0.5 MICRON CMOS Technology
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)
- Vcc = 3.3V ±0.3V, Normal Range
- Vcc = 2.7V to 3.6V, Extended Range
- CMOS power levels (0.4µW typ. static)
- · Rail-to-Rail output swing for increased noise margin
- · Available in QSOP package

DESCRIPTION:

The FCT3573/A are octal transparent latches built using an advanced dual metal CMOS technology.

These octal latches have 3-state outputs and are intended for bus oriented applications. The flip-flops appear transparent to the data when Latch Enable (LE) is high. When LE is low, the data that meets the set-up time is latched. Data appears on the bus when the Output Enable (\overline{OE}) is low. When \overline{OE} is high, the bus output is in the high-impedance state.

FUNCTIONAL BLOCK DIAGRAM

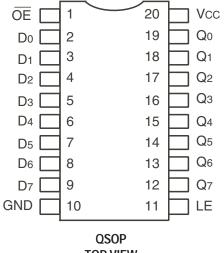


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OCTOBER 2009

INDUSTRIAL TEMPERATURE RANGE

PIN CONFIGURATION



TOP VIEW

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Description	Max	Unit	
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +4.6	V	
VTERM ⁽³⁾	Terminal Voltage with Respect to GND -0.5 to +7			
VTERM ⁽⁴⁾	Terminal Voltage with Respect to GND	-0.5 to Vcc+0.5	V	
Tstg	Storage Temperature	-65 to +150	°C	
Ιουτ	DC Output Current	-60 to +60	mA	

NOTES:

- 1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- 2. Vcc terminals.
- 3. Input terminals.
- 4. Outputs and I/O terminals.

CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Тур.	Max.	Unit
CIN	Input Capacitance	VIN = 0V	3.5	6	pF
Соит	Output Capacitance	Vout = 0V	4	8	pF

NOTE:

1. This parameter is measured at characterization but not tested.

PIN DESCRIPTION

Pin Names	Description	
Dx Data Inputs		
LE Latch Enable Input (Active HIGH)		
OE Output Enable Input (Active LOW)		
Qx	3-State Outputs	

FUNCTION TABLE⁽¹⁾

	Outputs		
Dx	LE	ŌĒ	Qx
Н	Н	L	Н
L	Н	L	L
Х	Х	Н	Z

NOTE:

1. H = HIGH Voltage Level

- X = Don't Care
- L = LOW Voltage Level
- Z = High Impedance

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified: Industrial: $T_A = -40^{\circ}C$ to $+85^{\circ}C$, $V_{CC} = 2.7V$ to 3.6V

Symbol	Parameter	Test Conditions ⁽¹⁾		Min.	Typ. ⁽²⁾	Max.	Unit
Vih	Input HIGH Level (Input pins)	Guaranteed Logic HIGH Level		2	_	5.5	V
	Input HIGH Level (I/O pins)			2	_	Vcc+0.5	
VIL	Input LOW Level	Guaranteed Logic LOW Level		-0.5	_	0.8	V
	(Input and I/O pins)						
Ін	Input HIGH Current (Input pins)	Vcc = Max.	VI = 5.5V	-	_	±1	μA
	Input HIGH Current (I/O pins)		VI = VCC	_	_	±1	
lil	Input LOW Current (Input pins)		VI = GND	-	_	±1	
	Input LOW Current (I/O pins)		VI = GND	_	_	±1	
lozн	High Impedance Output Current	Vcc = Max.	Vo = Vcc	-	_	±1	μA
Iozl	(3-State Output pins)		Vo = GND	_	_	±1	
Vik	Clamp Diode Voltage	Vcc = Min., IIN = -18mA		-	-0.7	-1.2	V
Iodh	Output HIGH Current	VCC = $3.3V$, VIN = VIH or VIL, VO = $1.5V^{(3)}$		-36	-60	-110	mA
IODL	Output LOW Current	VCC = 3.3V, VIN = VIH or VIL, VO =	= 1.5V ⁽³⁾	50	90	200	mA
Vон	Output HIGH Voltage	Vcc = Min.	Iон = -0.1mA	Vcc-0.2	_	_	V
		VIN = VIH or VIL	Iон = –3mA	2.4	3	—	
		Vcc = 3V	Iон = –8mA	2.4 ⁽⁵⁾	3	_	
		VIN = VIH or VIL					
Vol	Output LOW Voltage	Vcc = Min.	IOL = 0.1mA	_	_	0.2	V
		VIN = VIH or VIL	IOL = 16mA	_	0.2	0.4	
			Iol = 24mA	_	0.3	0.55	
		Vcc = 3V	IOL = 24mA		0.3	0.5	
		VIN = VIH or VIL					
los	Short Circuit Current ⁽⁴⁾	Vcc = Max., Vo = GND ⁽³⁾		-60	-135	-240	mA
Vн	Input Hysteresis	_		_	150	_	mV
ІССL ІССН ІССZ	Quiescent Power Supply Current	Vcc = Max., Vin = GND or Vcc		-	0.1	10	μA

NOTES:

1. For conditions shown as Min. or Max., use appropriate value specified under Electrical Characteristics for the applicable device type.

2. Typical values are at Vcc = 3.3V, +25°C ambient and maximum loading.

3. Not more than one output should be tested at one time. Duration of the test should not exceed one second.

4. This parameter is guaranteed but not tested.

5. VOH = Vcc - 0.6V at rated current.

POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾		Min.	Тур. ⁽²⁾	Max.	Unit
lcc	Quiescent Power Supply Current	Vcc = Max.	VIN = VCC - 0.6V	_	2	30	μA
ICCD	Dynamic Power Supply Current ⁽⁴⁾	Vcc = Max. Outputs Open OE = GND	Vin = Vcc Vin = GND	_	60	85	μΑ/ MHz
		One Input Toggling 50% Duty Cycle					
lc	Total Power Supply Current ⁽⁶⁾	Vcc = Max. Outputs Open fi = 10MHz	Vin = Vcc Vin = GND	_	0.6	0.9	mA
		50% Duty Cycle OE = GND LE = Vcc One Bit Toggling	VIN = VCC - 0.6V VIN = GND	_	0.6	0.9	
		Vcc = Max. Outputs Open fi = 2.5MHz	Vin = Vcc Vin = GND	—	1.2	1.7(5)	
		50% Duty Cycle OE = GND LE = Vcc Eight Bits Toggling	VIN = VCC - 0.6V VIN = GND	_	1.2	1.8(5)	

NOTES:

1. For conditions shown as Min. or Max., use appropriate value specified under Electrical Characteristics for the applicable device type.

- 2. Typical values are at Vcc = 3.3V, +25°C ambient.
- 3. Per TTL driven input. All other inputs at Vcc or GND.
- 4. This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.
- 5. Values for these conditions are examples of Δ Icc formula. These limits are guaranteed but not tested.
- 6. IC = IQUIESCENT + INPUTS + IDYNAMIC
 - IC = ICC + Δ ICC DHNT + ICCD (fCPNCP/2 + fiNi)
 - Icc = Quiescent Current (Icc, Iccн, and Iccz)
 - ΔIcc = Power Supply Current for a TTL High Input
 - DH = Duty Cycle for TTL Inputs High
 - $\ensuremath{\mathsf{N}}\xspace \mathsf{T}$ = Number of TTL Inputs at $\ensuremath{\mathsf{D}}\xspace \mathsf{H}$
 - ICCD = Dynamic Current caused by an Input Transition Pair (HLH or LHL)
 - fcp = Clock Frequency for register devices (zero for non-register devices)
 - NCP = Number of clock inputs at fCP
 - fi = Input Frequency
 - Ni = Number of Inputs at fi

SWITCHING CHARACTERISTICS OVER OPERATING RANGE⁽¹⁾

			74FCT3573		74FCT3573A		
Symbol	Parameter	Condition ⁽²⁾	Min. ⁽³⁾	Max.	Min. ⁽³⁾	Max.	Unit
tplh	Propagation Delay	CL = 50pF	1.5	8	1.5	5.2	ns
t PHL	Dx to Qx	$RL = 500\Omega$					
tplh	Propagation Delay		2	13	2	8.5	ns
t PHL	LE to Qx						
tрzн	Output Enable Time		1.5	12	1.5	6.5	ns
tPZL							
tphz	Output Disable Time		1.5	7.5	1.5	5.5	ns
tplz							
ts∪	Set-up Time HIGH or LOW, Dx to LE		2	—	2	_	ns
tH	Hold Time HIGH or LOW, Dx to LE		1.5	—	1.5	_	ns
tw	LE Pulse Width HIGH		6	_	5	_	ns

NOTES:

1. Propagation Delays and Enable/Disable times are with Vcc = 3.3V ±0.3V, Normal Range. For Vcc = 2.7V to 3.6V, Extended Range, all Propagation Delays and Enable/ Disable times should be degraded by 20%.

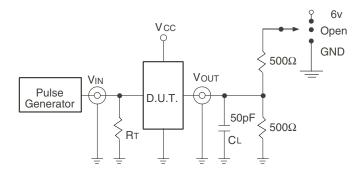
2. See test circuit and waveforms.

3. Minimum limits are guaranteed but not tested on Propagation Delays.

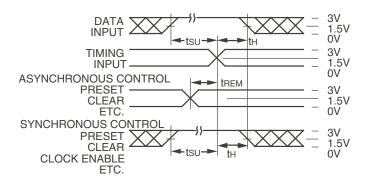
IDT74FCT3573/A 3.3V CMOS OCTAL TRANSPARENT LATCH

INDUSTRIAL TEMPERATURE RANGE

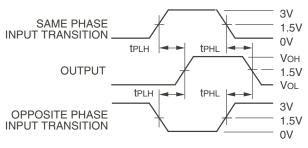
TEST CIRCUITS AND WAVEFORMS



Test Circuits for All Outputs







Propagation Delay

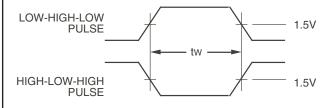
SWITCH POSITION

Test	Switch
Open Drain Disable Low Enable Low	6V
Disable High Enable High	GND
All Other Tests	Open

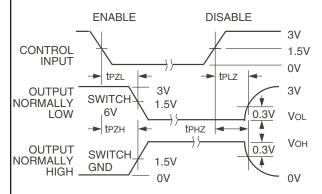
DEFINITIONS:

CL = Load capacitance: includes jig and probe capacitance.

RT = Termination resistance: should be equal to ZOUT of the Pulse Generator.



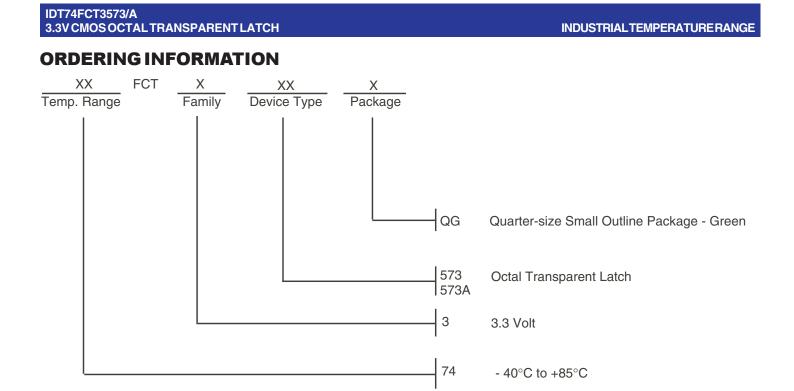
Pulse Width



Enable and Disable Times

NOTES:

- 1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.
- 2. Pulse Generator for All Pulses: Rate \leq 1.0MHz; Zo \leq 50Ω; tr \leq 2.5ns; tr \leq 2.5ns.
- 3. If Vcc is below 3V, input voltage swings should be adjusted not to exceed Vcc.



Datasheet Document History

10/03/09 Pg. 7 Updated the ordering information by removing the "IDT" notation and non RoHS part.

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